


<b>Search Notes</b>  	<b>Application/Control No.</b>  10581716	<b>Applicant(s)/Patent Under Reexamination</b>  CHERKAOUI ET AL.
	<b>Examiner</b>  Shean C Wu	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
west search, see attachment	6/6/10	sw
CAS on line structure based on the example 2, see attachment	6/6/10	sw

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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